

**Notice of References Cited**

Application/Control No.

10/761,257

Applicant(s)/Patent Under  
Reexamination  
O'DEA ET AL.

Examiner

Christopher P. Schwartz

Art Unit

3683

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,196,643 b1	03-2001	Yokoyama et al.	303/166
	B	US-6,241,323 b1	06-2001	Wagner et al.	303/113.4
	C	US-6,290,306 b1	09-2001	Friedow, Michael	303/113.3
	D	US-6,361,126 b1	03-2002	Pueschel et al.	303/114.3
	E	US-6,364,429 b1	04-2002	Roden et al.	303/114.3
	F	US-6,390,568 b1	05-2002	Tozu et al.	303/114.3
	G	US-6,623,088 b2	09-2003	Roden et al.	303/113.1
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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